

## **MOSFET**

### OptiMOS<sup>™</sup> Power-MOSFET, 25 V

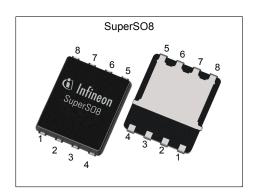
### **Features**

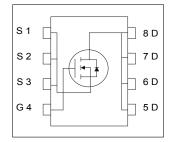
- Optimized for high performance Buck converter Very low on-resistance  $R_{\rm DS(on)}$  @  $V_{\rm GS}$ =4.5 V 100% avalanche tested

- Superior thermal resistance
- N-channel
- Qualified according to JEDEC<sup>1)</sup> for target applications
  Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21



Parameter	Value	Unit	
<b>V</b> <sub>DS</sub>	25	V	
R <sub>DS(on),max</sub>	5.0	mΩ	
I <sub>D</sub>	58	Α	
$Q_{GD}$	1.3	nC	
Q <sub>G</sub> (0V10V)	10.4	nC	











Type / Ordering Code	Package	Marking	Related Links
BSC050NE2LS	PG-TDSON-8	050NE2LS	-



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1 Maximum ratings at  $T_j$ =25 °C, unless otherwise specified

Table 2 **Maximum ratings** 

Parameter	0		Value	s		
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I <sub>D</sub>		- - - -	58 37 49 31 39	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 K/W <sup>1)</sup>
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	232	Α	T <sub>C</sub> =25 °C
Avalanche current, single pulse <sup>3)</sup>	I <sub>AS</sub>	-	-	35	Α	<i>T</i> <sub>C</sub> =25 °C
Avalanche energy, single pulse	<b>E</b> AS	-	-	12	mJ	$I_D$ =35 A, $R_{GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	28 2.5	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =50 K/W <sup>1)</sup>
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

#### 2 **Thermal characteristics**

Table 3 **Thermal characteristics** 

Davamatav	Cumbal	Values			11	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	4.5	K/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	-	20	K/W	-
Device on PCB, 6 cm <sup>2</sup> cooling area <sup>1)</sup>	R <sub>thJA</sub>	_	-	50	K/W	-

 $<sup>^{1)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.  $^{2)}$  See figure 3 for more detailed information  $^{3)}$  See figure 13 for more detailed information



# 3 Electrical characteristics at $T_j$ =25 °C, unless otherwise specified

Table 4 **Static characteristics** 

Parameter	0	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	25	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA
Gate threshold voltage	V <sub>GS(th)</sub>	1.2	-	2	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \ \mu {\rm A}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	1 100	μΑ	V <sub>DS</sub> =25 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =25 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	5.7 4.2	7.1 5.0	mΩ	V <sub>GS</sub> =4.5 V, I <sub>D</sub> =30 A V <sub>GS</sub> =10 V, I <sub>D</sub> =30 A
Gate resistance	R <sub>G</sub>	0.3	0.65	1.3	Ω	-
Transconductance	<b>g</b> fs	38	75	-	S	$ V_{DS}  > 2 I_D R_{DS(on)max}, I_D = 30 \text{ A}$

Table 5 **Dynamic characteristics** 

Parameter	Comple al	Values			11	Nata / Tank Oam distant
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	760	1011	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =12 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	320	426	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =12 V, <i>f</i> =1 MHz
Reverse transfer capacitance	C <sub>rss</sub>	-	35	-	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =12 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{ m d(on)}$	-	2.5	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	2.2	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{\sf d(off)}$	-	11.4	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	2.0	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Gate charge characteristics<sup>1)</sup> Table 6

Parameter	Cumbal	Values			11	Nata / Tast Candition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	$Q_{gs}$	-	2.2	3	nC	V <sub>DD</sub> =12 V, I <sub>D</sub> =30 A, V <sub>GS</sub> =0 to 4.5 V
Gate charge at threshold	$Q_{g(th)}$	-	1.2	-	nC	$V_{\rm DD}$ =12 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate to drain charge	$Q_{\mathrm{gd}}$	-	1.3	2.0	nC	V <sub>DD</sub> =12 V, I <sub>D</sub> =30 A, V <sub>GS</sub> =0 to 4.5 V
Switching charge	Q <sub>sw</sub>	-	2.2	-	nC	V <sub>DD</sub> =12 V, I <sub>D</sub> =30 A, V <sub>GS</sub> =0 to 4.5 V
Gate charge total	Qg	-	5.0	7	nC	$V_{\rm DD}$ =12 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate plateau voltage	V <sub>plateau</sub>	-	2.8	-	V	$V_{\rm DD}$ =12 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5 V
Gate charge total	Qg	-	10.4	14	nC	$V_{\rm DD}$ =12 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	4.3	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 4.5 V
Output charge	Qoss	-	6.4	8.5	nC	V <sub>DD</sub> =12 V, V <sub>GS</sub> =0 V

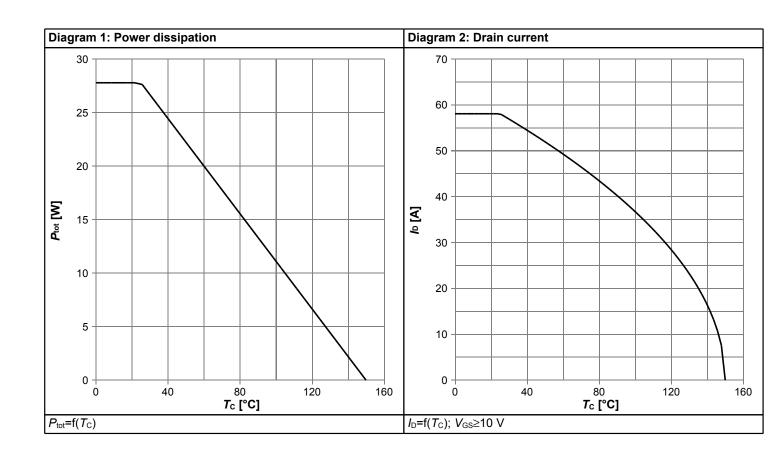


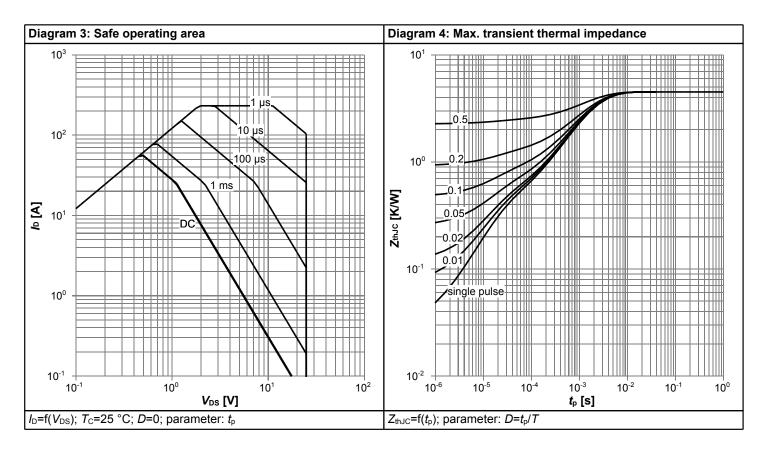
### Table 7 Reverse diode

Parameter	Cumbal		Values			Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	I <sub>S</sub>	-	-	28	Α	T <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	112	Α	T <sub>C</sub> =25 °C
Diode forward voltage	V <sub>SD</sub>	-	0.89	1	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =30 A, T <sub>j</sub> =25 °C
Reverse recovery charge	Qrr	-	5	-	nC	V <sub>R</sub> =15 V, I <sub>F</sub> =I <sub>S</sub> , di <sub>F</sub> /dt=400 A/μs

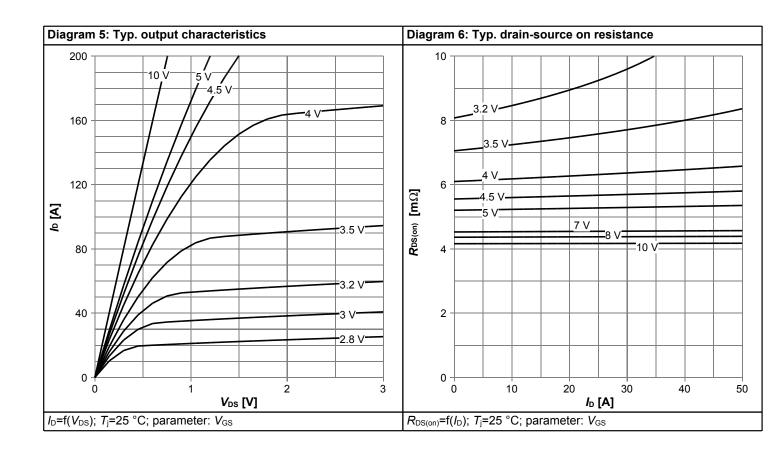


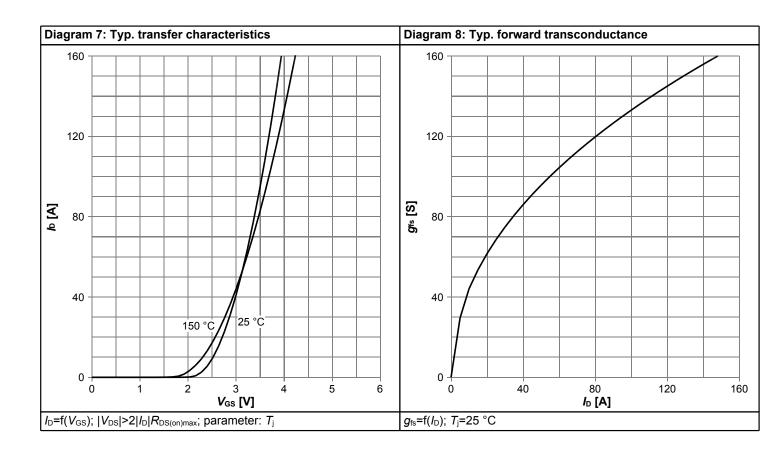
## 4 Electrical characteristics diagrams



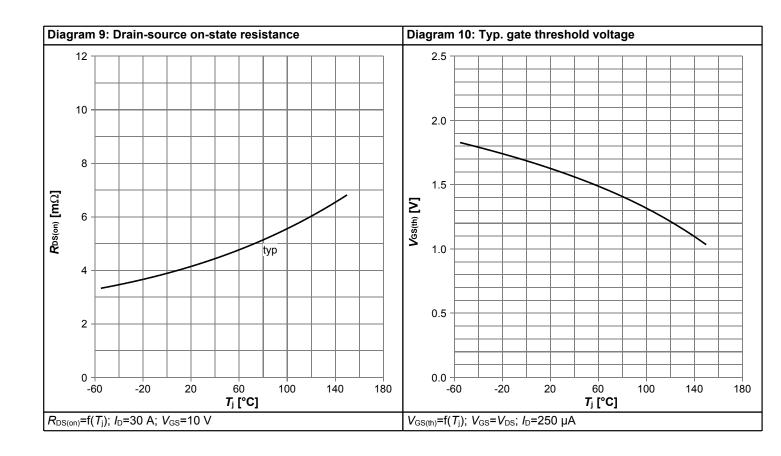


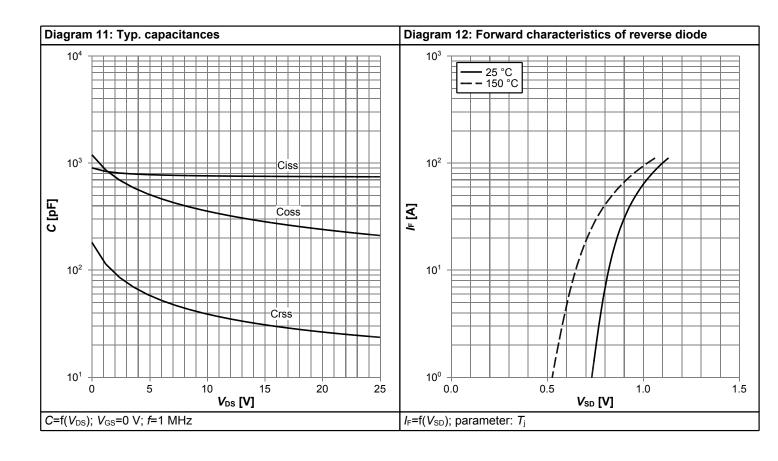




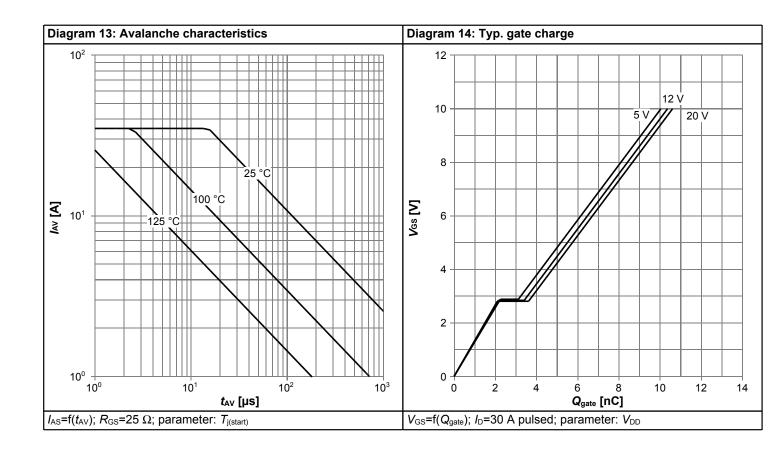


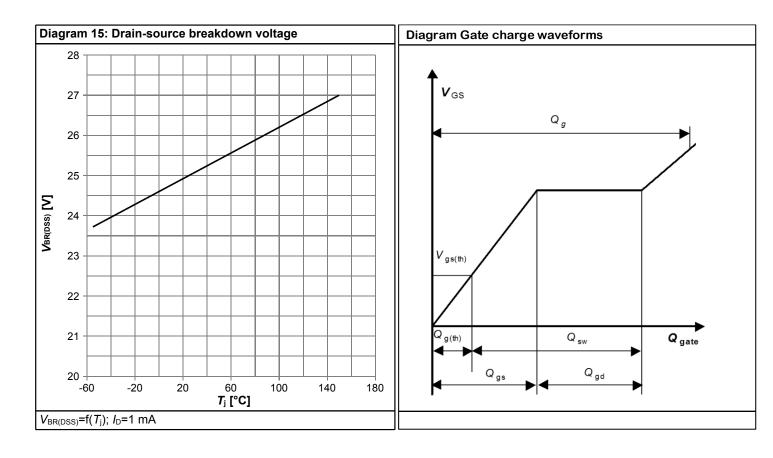






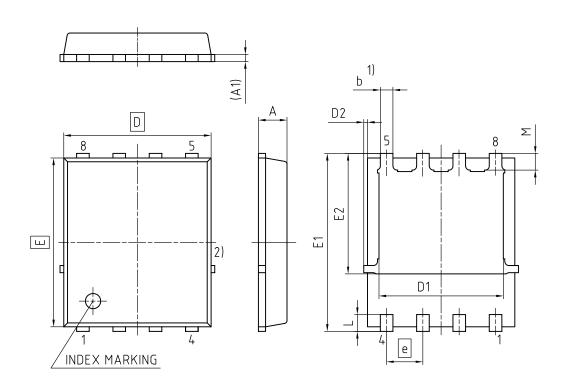








# 5 Package Outlines



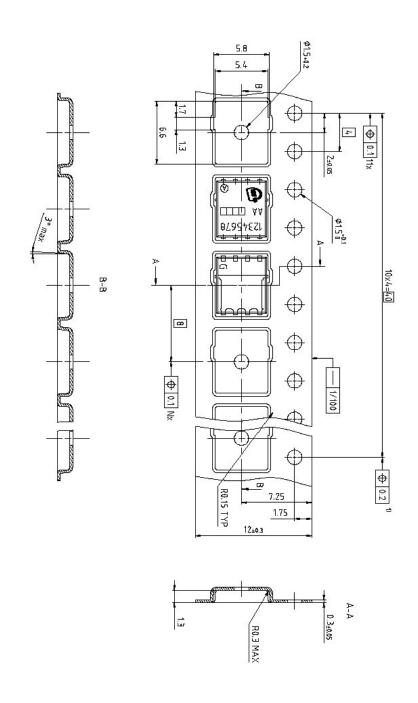
1) EXCLUDING MOLD FLASH
2) REMOVAL ON MOLD GATE
INTRUSION 0.1 MM
PROTRUSION 0.1 MM
LEAD LENGTH UP TO ANTI FLASH LINE
ALL METAL SURFACES ARE PLATED, EXCEPT AREA OF CUT

DIMENSION	MILLIM	ETERS				
DIMENSION	MIN.	MAX.				
Α	0.90	1.20				
A1	0.15	0.35				
b	0.34	0.54				
D	4.80	5.35				
D1	3.90	4.40				
D2	0.03	0.23				
E	5.70	6.10				
E1	5.90	6.42				
E2	3.88	4.31				
е	1.27					
L	0.45 0.71					
M	0.45	0.69				

Z8B00003332
REVISION 07
SCALE 10:1
0 1 2 3mm
EUROPEAN PROJECTION
ISSUE DATE 06.06.2019

Figure 1 Outline PG-TDSON-8, dimensions in mm





Dimension in mm

Figure 2 Outline Tape (TDSON-8)



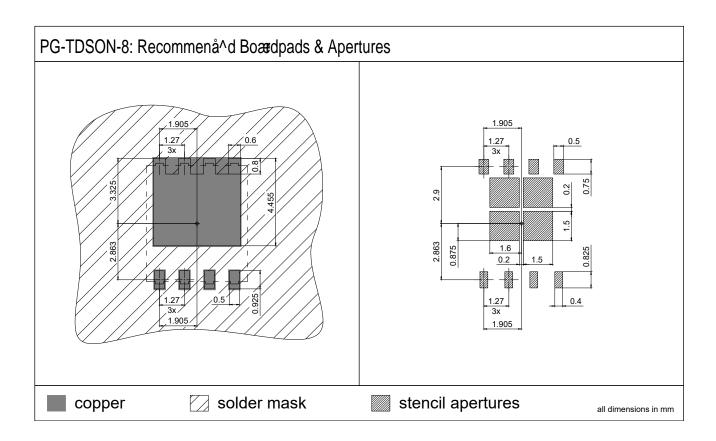


Figure 3 Outline Boardpads (TDSON-8), dimensions in mm

# OptiMOS TM Power-MOSFET, 25 V BSC050NE2LS



### Revision History

### BSC050NE2LS

Revision: 2019-11-04, Rev. 2.4

### **Previous Revision**

Revision	Date	Subjects (major changes since last revision)
2.4	2019-11-04	Update package drawings

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